Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination TAKASU ET AL. | Examiner | Art Unit | John S. Chu | 1752 | Page 1 of 1 | U.S. PATENT DOCUMENTS

C.S. FATERT DOCUMENTS				
	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
Α	US-2003/0134232 A1	07-2003	Yokoyama et al.	430/312
В	US-			430/312
С	US-			
D	US-			
Е	US-			<u> </u>
F	US-			
G	US-			
Н	US-			
-	US-			
J	US-			
к	US-			
L	US-			
м	US-			
	B C D E F G H I J K L	A US-2003/0134232 A1 B US- C US- D US- E US- F US- G US- H US- I US- J US- K US- L US-	Country Code-Number-Kind Code MM-YYYY A US-2003/0134232 A1 07-2003 B US- C US- D US- E US- F US- G US- H US- I US- J US- K US- L US-	Document Number Country Code-Number-Kind Code MM-YYYY Name

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
丁	Т					

NON-PATENT DOCUMENTS

$\overline{}$	MON-L MIENT DOCUMENTS			
*	Ī	Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)		
		, and a state of the state of t		
1	lυ			
	-			
	_			
	lv			
ļ	°			
	<u> </u>			
	W			
	Х			
ĺ				
'A cor	ov of thi	s reference is not being furnished with this Cur.		

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.